

Notice of References Cited	Application/Control No. 10/764,423		Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Steven E. Holton		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,198,485	03-2001	Mack et al.	345/419
*	B	US-5,926,190	07-1999	Turkowski et al.	345/473
*	C	US-6,753,879	06-2004	Deleeuw, William C.	345/629
*	D	US-5,682,332	10-1997	Ellenby et al.	702/150
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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